

2N6674, 2N6675, RJH6674, RJH6675

File Number 1164

HARRIS SEMICONDUCTOR

27E D

4302271 0020054 7 HAS

10-A **SwitchMax**
Power Transistors

High-Voltage N-P-N Types for Off-Line Power Supplies and Other High-Voltage Switching Applications

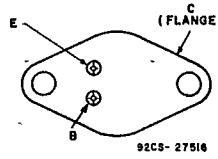
Features:

- Fast switching speed
- High voltage ratings:
V_{CEX}=350 V to 450 V
- Low V_{CE(sat)} at I_C=10 A

Applications:

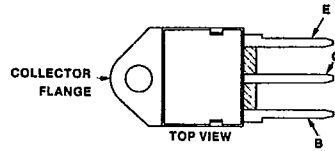
- Off-line power supplies
- High-voltage inverters
- Switching regulators

TERMINAL DESIGNATIONS



JEDEC TO-204AA

2N6674
2N6675



JEDEC TO-218AC

RJH6674
RJH6675

The 2N6674, 2N6675, RJH6674, and RJH6675 SwitchMax series of silicon n-p-n power transistors feature high-voltage capability, fast switching speeds, and low saturation voltages, together with high safe-operating-area (SOA) ratings. They are specially designed for off-line power supplies, converter circuits, and pulse-width-modulated regulators. These high-voltage, high-speed transistors are tested for parameters that are essential to the design of high-power switching circuits. Switching times, including inductive turn-off time, and

saturation voltages are specified at 100°C to provide information necessary for worst-case design.

The 2N6674 and 2N6675 transistors are supplied in steel JEDEC TO-204AA hermetic packages. The RJH6674 and RJH6675 transistors are supplied in JEDEC TO-218AC plastic packages.

MAXIMUM RATINGS, Absolute-Maximum Values:

	RJH6674	RJH6675	2N6674	2N6675	
*V _{CEV}					
V _{BE} =-1.5 V	450	650	450	650	V
*V _{CEX} (Clamped)					
V _{BE} =-1.5 V	350	450	350	450	V
*V _{CEO}	300	400	300	400	V
*V _{EB0}			7		V
I _C (Sat)			10		A
*I _C			15		A
I _{CM}			20		A
*I _B			5		A
*P _T					
T _C up to 25° C			175		W
T _C above 25° C, derate linearly	1.4	1.4	1	1	W/°C
*T _{sig} , T _J		-65 to 150		-65 to 200	°C
*T _L					
At distance ≥ 1/16 in. (1.58 mm) from seating plane for 10 s max				235	°C
TL					
At distance ≥ 1/8" in (3.17 mm) from seating plane for 10 s max		235			°C

*In accordance with JEDEC registration data (2N6674, 2N6675 only).

2N6674, 2N6675, RJH6674, RJH6675

ELECTRICAL CHARACTERISTICS

T-33-15

CHARACTERISTIC	TEST CONDITIONS				LIMITS				UNITS
	VOLTAGE V dc		CURRENT A dc		2N6674 RJH6674		2N6675 RJH6675		
	V _{CE}	V _{BE}	I _C	I _B	Min.	Max.	Min.	Max.	

T_C=25° C

I _{CEV}	450 650	-1.5 -1.5			—	0.1	—	—	mA
I _{EBO}		-7	0		—	2	—	2	
V _{CE0(sus)} ^b			0.2 ^a	0	300	—	400	—	V
h _{FE}	2		10 ^a		8	20	8	20	
V _{BE(sat)}			10 ^a	2	—	1.5	—	1.5	V
V _{CE(sat)}			10 ^a 15 ^a	2 5	—	1 5	—	1 5	
V _{CEX} ^b (Clamped E _s) L=50 μH, R _{EB} =2 Ω		-4	10	2	350	—	450	—	
I _S	30 100		5.9 0.25		1 1	—	1 1	—	s
h _{ie} f=5 MHz	10		1		3	10	3	10	
f _T	10		1		15	50	15	50	MHz
C _{ob0} f=0.1 MHz	10 ^c				150	500	150	500	pF
t _d ^d		-6	10	2	—	0.1	—	0.1	μs
t _r ^d		-6	10	2	—	0.6	—	0.6	
t _s ^d		-6	10	2 ^e	—	2.5	—	2.5	
t _f ^d		-6	10	2 ^e	—	0.5	—	0.5	
t _c V _{CC} =135 V, L=50 μH, R _C ≤ 13.5 Ω, Collector clamped to V _{CEX}		-6	10	2 ^e	—	0.5	—	0.5	

T_C=100° C

I _{CEV}	450 650	-1.5 -1.5			—	1	—	—	mA
V _{CE(sat)}			10 ^a	2	—	2	—	2	V
t _d ^d		-6	10	2	—	1	—	1	μs
t _r ^d		-6	10	2 ^e	—	4	—	4	
t _s ^d		-6	10	2 ^e	—	1	—	1	
t _f ^d		-6	10	2 ^e	—	1	—	1	
t _c V _{CC} =135 V, L=50 μH, R _C ≤ 13.5 Ω, Collector clamped to V _{CEX}		-6	10	2 ^e	—	0.8	—	0.8	

R _{θJC} 2N6674, 2N6675	10		5		—	1	—	1	°C/W
R _{θJC} RJH6674, RJH6675	10		5		—	0.71	—	0.71	°C/W

^aPulsed: pulse duration=300 μs, duty factor ≤ 2%.

^bCAUTION: The sustaining voltage V_{CE0(sus)} and V_{CEX} MUST NOT be measured on a curve tracer.

^cIn accordance with JEDEC registration data (2N6674, 2N6675 only).

^dV_{CE} value.

^eV_{CC}=135 V, t_p=20 μs.

^eI_{B1}=-I_{B2}.



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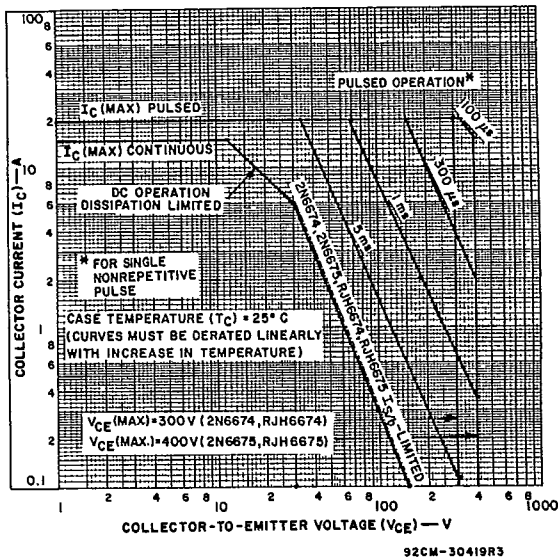


Fig. 1 - Maximum operating areas for all types ($T_c=25^\circ\text{C}$).

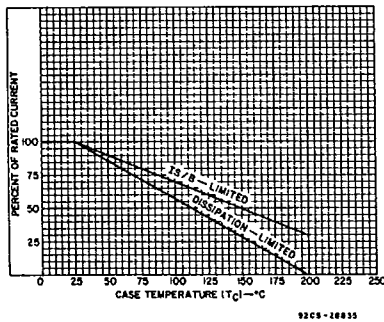


Fig. 2 — Dissipation and $I_{s,b}$ derating curves for 2N6674 and 2N6675.

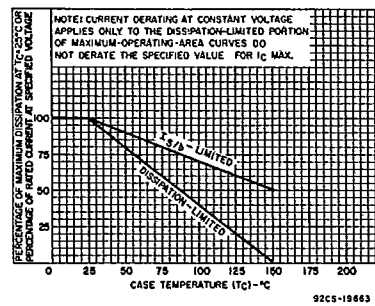


Fig. 3 — Dissipation and $I_{s,b}$ derating curves for RJH6674 and RJH6675.

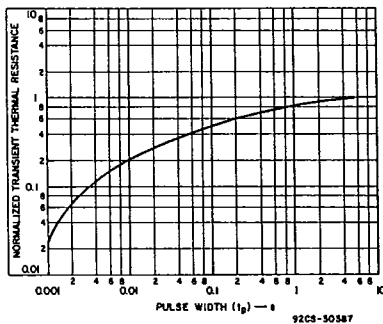


Fig. 4 - Typical thermal-response characteristic for all types.

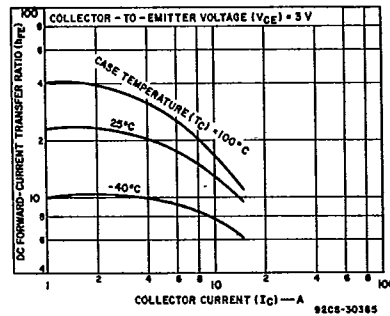


Fig. 5 - Typical dc beta characteristics for all types.

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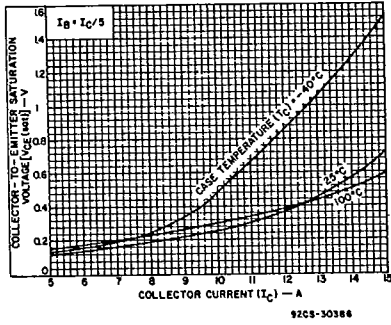


Fig. 6 - Typical collector-to-emitter saturation voltage characteristics for all types.

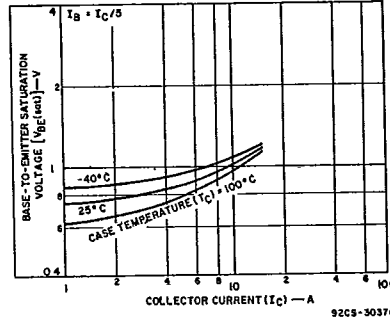


Fig. 7 - Typical base-to-emitter saturation voltage characteristics for all types.

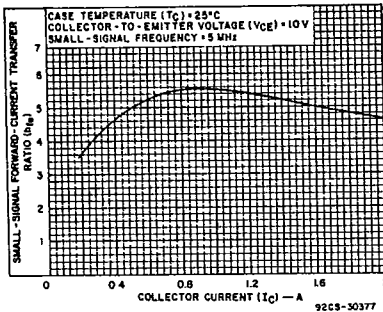


Fig. 8 - Typical small-signal forward current transfer ratio characteristic for all types ($f=5$ MHz).

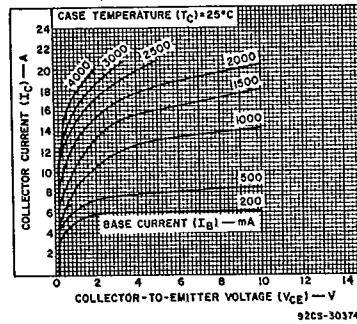


Fig. 9 - Typical output characteristics for all types.

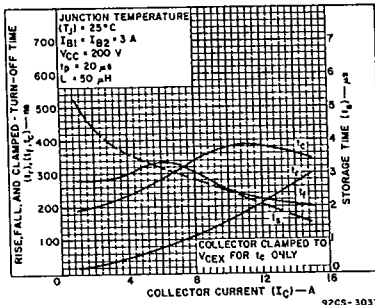


Fig. 10 - Typical saturated-switching-time characteristics at $T_J=25^\circ\text{C}$ as a function of collector current for all types.

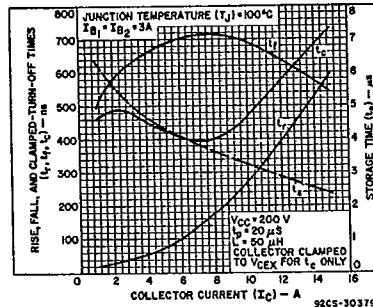


Fig. 11 - Typical saturated-switching-time characteristics at $T_J=100^\circ\text{C}$ as a function of collector current for all types.

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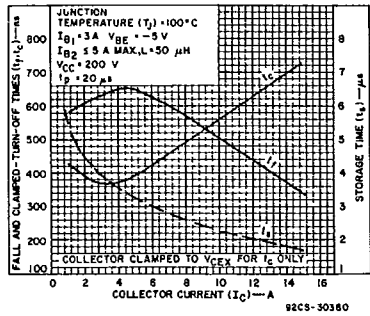


Fig. 12 - Typical saturated-switching-time characteristics at $T_j=100^\circ\text{C}$ as a function of collector current for all types.

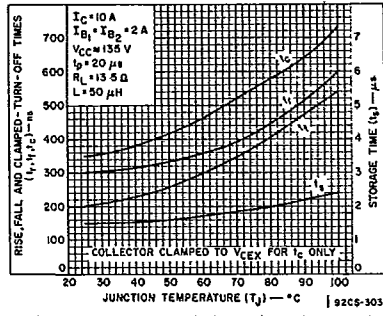


Fig. 13 - Typical saturated-switching-time characteristics as a function of junction temperature for all types.

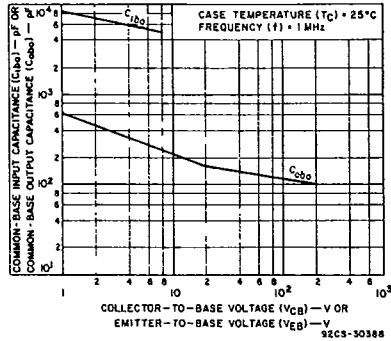


Fig. 14 - Typical common-base input (C_{ibo}) or output (C_{obo}) capacitance characteristics for all types.

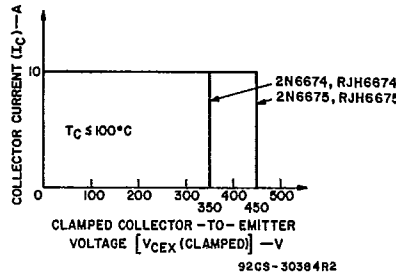


Fig. 15 - Maximum operating conditions for switching between saturation and cutoff for all types.

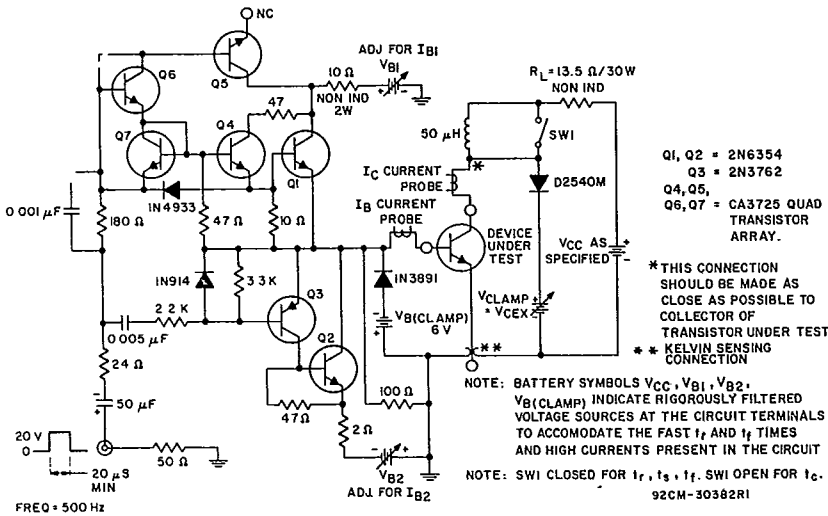


Fig. 16 - Circuit for measuring switching times.

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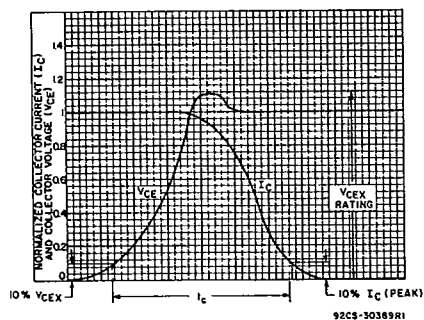
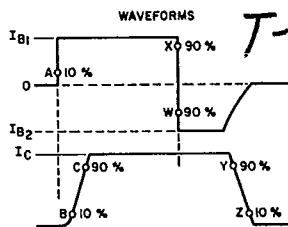


Fig. 17 - Oscilloscope display for normalized measurement of clamped inductive switching time (t_c).



$t_d = A-B$ $t_s = X-Y$
 $t_r = B-C$ $t_f = Y-Z$
 $t_{transition} = X-W$
 NOTE TRANSITION TIME FROM 90% I_{B1} TO 90% I_{B2} MUST BE LESS THAN 0.5 μs .
 92CS-30381R1



Fig. 18 - Phase relationship between input and output currents showing reference points for specification of switching times.